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## Surface Morphology and Wettability of Ultrananocrystalline Diamond Films

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At the present time, ultrananocrystalline diamond/hydrogenated amorphous carbon composite (UNCD/a-C:H) films have been attracting significant attention owing to their potential application in superhydrophobic surface. The wettability properties of diamond-like carbon (DLC) films have ever been investigated. Conversely, few reports have been carried out in terms of examining the wettability properties based on UNCD films. In the current research, the surface morphology and wettability properties of UNCD films were explored. UNCD films were produced onto Si wafers via usage of coaxial arc plasma deposition (CAPD) at a substrate temperature of 550 °C. The surface morphology view of UNCD films was explored using field emission scanning electron microscopy (FESEM) and atomic force microscopy (AFM). The wettability of the film surface was determined using contact angle measurement. It was observed from the FESEM image that the produced UNCD films consisted of a large amount of crystallites with diameters of lower than 10 nm. The AFM scanning result demonstrated that the surface of the UNCD films was smooth with a root mean square roughness of 3.0 nm. The average contact angle between water droplet and UNCD film was 90.8 degrees. From the acquired result, the surface of the UNCD film exhibited hydrophobic properties. It was demonstrated that the UNCD films produced by means of CAPD could potentially be applied to hydrophobic surface.